AMENDMENTS TO CLAIMS

Please cancel claims 1, 22-31, 33-36, 38, 40, 43, 61, 63, 65, and 67, and amend claims 3-15, 18-20, 32, 37, 39, 44, 45, 47-49, 51-53, 55-57, and 59. Claims 2, 16, and 17 were previously canceled, claims 41, 42, 46, 50, 54, and 58 were previously withdrawn. All pending claims are reproduced below, including those that remain unchanged.

- 1. (Canceled).
- 2. (Canceled).
- 3. (Currently amended) The A method of claim 1 for shaping optical elements. comprising:

creating an annular plasma;

injecting a flow of a species into the annulus center of the annular plasma to create at least one reactive species; and using reactive atom plasma processing for the damage-free shaping of a surface.

4. (Currently amended) The A method of claim 1 for shaping elements out of silicon, comprising:

creating an annular plasma;

injecting a flow of a species into the annulus center of the annular plasma to create at least one reactive species; and using reactive atom plasma processing for the damage-free shaping of a surface.

5. (Currently amended) The A method of claim 1 for shaping silica glass optics. comprising:

creating an annular plasma;

injecting a flow of a species into the annulus center of the annular plasma

to create at least one reactive species; and
using reactive atom plasma processing for the damage-free shaping of a
surface.

6. (Currently amended) The A method of claim 1 for shaping aspheric optics., comprising:

creating an annular plasma; injecting a flow of a species into the annulus center of the annular plasma to create at least one reactive species; and using reactive atom plasma processing for the damage-free shaping of a surface.

- 7. (Currently amended) The method of claim 21 operating in a subtractive manner.
- 8. (Currently amended) The A method of claim 1 for shaping surfaces, comprising:

 creating an annular plasma;

 injecting a flow of a species into the annulus center of the annular plasma
 to create at least one reactive species;
 using reactive atom plasma processing for the damage-free shaping of a
 surface; and
 operating so as not to leave behind a contaminated redeposition layer.
- 9. (Currently amended) The method of claim 21 using a plume of the plasma.
- 10. (Currently amended) The method of claim <u>2</u>1 using a plume of the plasma operating as a sub-aperture tool.
- 11. (Currently amended) The method of claim 21 wherein a plume of the plasma is translated across a workpiece.
- 12. (Currently amended) The A method of claim 1 wherein for shaping surfaces,

comprising:

creating an annular plasma;

injecting a flow of a species into the annulus center of the annular plasma to create at least one reactive species;

using reactive atom plasma processing for the damage-free shaping of a surface; and

monitoring an emission spectrum is monitored to determine process rates.

13. (Currently amended) The A method of claim 1 for shaping surfaces, comprising: creating an annular plasma;

injecting a flow of a species into the annulus center of the annular plasma to create at least one reactive species;

using reactive atom plasma processing for the damage-free shaping of a surface; and

using carbon tetrafluoride (CF4) in argon to create the plasma.

14. (Currently amended) The A method of claim 1 for shaping surfaces, comprising: creating an annular plasma;

injecting a flow of a species into the annulus center of the annular plasma to create at least one reactive species;

using reactive atom plasma processing for the damage-free shaping of a surface; and

using C2F6 in argon to create the plasma.

15. (Currently amended) The A method of claim 1 for shaping surfaces, comprising: creating an annular plasma;

injecting a flow of a species into the annulus center of the annular plasma to create at least one reactive species;

using reactive atom plasma processing for the damage-free shaping of a surface; and

using sulfur hexafluoride (SF6) in argon to create the plasma.

16.	(Canceled).
17.	(Canceled).
18.	(Currently amended) The method of claim 21 operating in an additive manner.
19.	(Currently amended) The method of claim 21 for removing damage introduced by previous process steps.
20.	(Currently amended) The method of claim 21 for removing surface roughness.
21.	(Previously presented) A method for shaping surfaces, comprising: injecting a flow of a species into the center of an annular plasma to create at least one reactive species; and using reactive atom plasma processing to shape and polish a surface.
22.	(Canceled).
23.	(Canceled).
24.	(Canceled).
25.	(Canceled).
26.	(Canceled).
27.	(Canceled).
28.	(Canceled).
29.	(Canceled).

30. (Canceled). 31. (Canceled). 32. (Currently amended) The method of claim 21, further comprising: using the at least one reactive species to react with selected materials which comprise the surface. 33. (Canceled). 34. (Canceled). 35. (Canceled). 36. (Canceled). 37. (Currently amended) The method of claim 362 including the step of moving at least one of the plasma and the surface relative to the other. 38. (Canceled). 39. (Currently amended) The method of claim 3866 including the step of moving at least one of the plasma and the surface relative to the other. 40. (Canceled). 41. (Withdrawn) A method to clean a surface, comprising: creating a plasma; using a species which has been selected in order to react with selected

materials which comprise the surface and which reactive species does not

react with other materials of the surface;

injecting a flow of the species into the center of the plasma to create

reactive species; and

using reactive atom plasma processing to selectively clean the surface by allowing the reactive species to react with the selected materials which

comprise the surface without reacting with other materials of the surface.

42. (Withdrawn) The method of claim 41 including the step of moving at least one of

the plasma and the surface relative to the other.

43. (Canceled).

44. (Currently amended) The method of claim 360 operated at one of above and

below atmospheric pressure.

45. (Currently amended) The method of claim 3862 operated at one of above and

below atmospheric pressure.

46. (Withdrawn) The method of claim 41 operated at one of above and below

atmospheric pressure.

47. (Currently amended) The method of claim 4366 operated at one of above and

below atmospheric pressure.

48. (Currently amended) The method of claim 360 operable on one of a conductive

surface, a non-conductive surface, and a semiconductor surface.

49. (Currently amended) The method of claim 3862 operable on one of a conductive

surface, a non-conductive surface, and a semiconductor surface.

50. (Withdrawn) The method of claim 41 operable on one of a conductive surface, a

non-conductive surface, and a semiconductor surface.

7

- 51. (Currently amended) The method of claim 4366 operable on one of a conductive surface, a non-conductive surface, and a semiconductor surface.
- 52. (Currently amended) The method of claim 360 wherein the step of using reactive atom plasma processing to selectively shape the surface is a deterministic step which can be selectively in one of an additive mode and a subtractive mode.
- 53. (Currently amended) The method of claim 3862 wherein the step of using reactive atom plasma processing to selectively shape the surface is a deterministic step which can be selectively in one of an additive mode and a subtractive mode.
- 54. (Withdrawn) The method of claim 41 wherein the step of using reactive atom plasma processing to selectively shape the surface is a deterministic step which can be selectively in one of an additive mode and a subtractive mode.
- 55. (Currently amended) The method of claim 4366 wherein the step of using reactive atom plasma processing to selectively shape the surface is a deterministic step which can be selectively in one of an additive mode and a subtractive mode.
- 56. (Currently amended) The method of claim 360 operated at about atmospheric pressure and at one of above and below room temperature.
- 57. (Currently amended) The method of claim 3862 operated at about atmospheric pressure and at one of above and below room temperature.
- 58. (Withdrawn) The method of claim 41 operated at about atmospheric pressure and at one of above and below room temperature.
- 59. (Currently amended) The method of claim 4366 operated at about atmospheric pressure and at one of above and below room temperature.

60. (Previously presented) A method for shaping surfaces, comprising:

creating an annular plasma;

injecting a flow of a species into the center of the annular plasma to create at least one reactive species; and

using reactive atom plasma processing for the damage-free shaping of a surface to fit a pre-determined contour.

- 61. (Canceled).
- 62. (Previously presented) A method for shaping surfaces, comprising:

creating an annular plasma;

injecting a flow of a species into the center of the annular plasma to create at least one reactive species; and

shaping a surface deterministically and damage-free to fit a predetermined contour.

- 63. (Canceled).
- 64. (Previously presented) A method for shaping surfaces, comprising:

creating an annular plasma;

injecting a flow of a species into the center of the annular plasma to create at least one reactive species; and

using reactive atom plasma processing for the damage-free and deterministic shaping of a surface by at least one of:

selecting a part of the surface to shape;

selecting a material to shape on the surface; and

controlling the removal rate of a material on the surface under

shaping.

65. (Canceled).

66. (Previously presented) A method for shaping surfaces, comprising:

creating an annular plasma;

injecting a flow of a species into the center of the annular plasma to create at least one reactive species; and

shaping a surface deterministically and damage-free by at least one of:

selecting a part of the surface to shape;

selecting a material to shape on the surface; and

controlling the removal rate of a material on the surface under

shaping.

67. (Canceled).